Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/710,740	TSUEI ET AL.
Examiner	Art Unit

2876

Thien M. Le

SEARCHED					
Class	Subclass	Date	Examiner		
235	380				
	449				
	493				
•	375				
	379				
	382				
	382.5				
705	1,54		·		
	74,14				
	26,67				
709	204,206				
	248	6/22/2006	LTM		
updated		11/13/2006	LTM		

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
235	380					
	375	11/13/2006	LTM			
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST	6/22/2006	LTM
updated	11/13/2006	LTM
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